STRUCTURAL CHANGES DURING MELTING OF QUARTZ-FELDSPAR RAW MATERIALS IN LOW-TEMPERATURE PLASMA

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A detailed x-ray analysis of a quartz-feldspar raw materials as in the initial state and after plasma exposure. An amorphous product of fusion, the resulting plasma exposure, consists mixture of amorphous phases: $[O_2Si]$, $[O_{22}Al_{20}]$, $[O_{192}Si_{96}]$, $[O_{240}Si_{120}]$, a significant proportion of which are based on phase SiO2. It is established that the phase composition of the raw material consists of a mixture of ($[O_{22}Al_{20}]$ and $[O_2Si]$).

Keywords: quartz-feldspar raw materials, crystal structure, quantitative phase analysis.